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0.000				Application Number	10/713499		
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ST	STATEMENT BY APPLICANT			First Named Inventor	James E. Barger		
	(Use as man	v sheets e	s necessary)	Art Unit	2856		
	1000 00 111011	y 0.70010 E	,,,,,	Examiner Name	S. J. M. Saint		
Sheet	1	of	1	Attorney Docket Number	BBNT-P01-138		

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